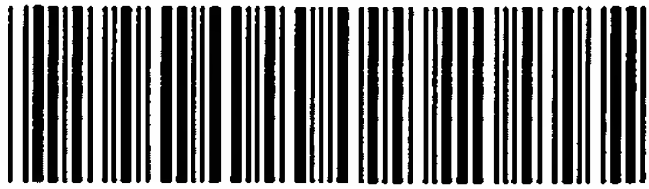


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/659,138	BALAJI ET AL.	
	Examiner	Art Unit	
	Sun J. Lin	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	4	10/25/2005	JSL
716	5	10/25/2005	JSL
709	203	10/25/2005	JSL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	4	10/25/2005	JSL
716	5	10/25/2005	JSL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/25/2005	JSL
IEEE	10/31/2005	JSL